

<b>Notice of References Cited</b>	Application/Control No. 10/762,173	Applicant(s)/Patent Under Reexamination OKUBO ET AL.	
	Examiner Irina S. Zemel	Art Unit 1711	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0123209	09-2002	Yamada et al.	438/432
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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